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M sem i t e k



SLF70R380E7C/SLP70R380E7C

# SLF70R380E7C / SLP70R380E7C

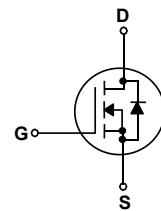
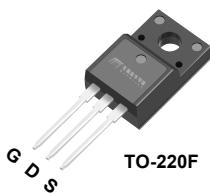
## 700V N-Channel Multi-EPI Super-JMOSFET

### General Description

This Power MOSFET is produced using Msemitek's advanced Superjunction MOSFET technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies.

### Features

- 11A, 700V@  $T_{J,max}$ ,  $R_{DS(on)Typ}=318m\Omega @ V_{GS} = 10V$
- Low gate charge(typ.  $Q_g = 16.0nC$ )
- High ruggedness
- Ultra fast switching
- 100% avalanche tested
- Improved dv/dt capability



### Absolute Maximum Ratings

$T_c = 25^\circ C$  unless otherwise noted

Symbol	Parameter	SLF70R380E7C / SLP70R380E7C		Units
$V_{DSS}$	Drain-Source Voltage	700		V
$I_D$	Drain Current - Continuous ( $T_c = 25^\circ C$ )	11*		A
	- Continuous ( $T_c = 100^\circ C$ )	6.1*		A
$I_{DM}$	Drain Current - Pulsed	(Note 1)		A
$V_{GSS}$	Gate-Source Voltage	28.8 *		V
EAS	Single Pulsed Avalanche Energy	(Note 2)		mJ
$I_{AR}$	Avalanche Current	(Note 1)		A
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)		mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)		20
	MOSFET dv/dt			100
$P_D$	Power Dissipation ( $T_c = 25^\circ C$ )	28	85	W
	- Derate above $25^\circ C$	0.22	0.68	W/ $^\circ C$
$T_J, T_{STG}$	Operating and Storage Temperature Range	-55 to +150		$^\circ C$
$T_L$	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	260		$^\circ C$

\* Drain current limited by maximum junction temperature.

### Thermal Characteristics

Symbol	Parameter	SLF70R380E7C / SLP70R380E7C		Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	4.5	1.47	$^\circ C/W$
$R_{\theta JS}$	Thermal Resistance, Case-to-Sink Typ.		-	$^\circ C/W$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	54.8	$^\circ C/W$

## Package Marking

Part Number	Top Marking	Package	Packing Method	MOQ	QTY
SLF70R380E7C	SLF70R380E7C	TO-220F	Tube	1000	5000
SLP70R380E7C	SLP70R380E7C	TO-220C	Tube	1000	5000

## Electrical Characteristics

T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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### Off Characteristics

BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 1mA	700	--	--	V
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 1mA, T <sub>J</sub> = 150°C	700	--	--	V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 650 V, V <sub>GS</sub> = 0 V	--	--	1.0	uA
		V <sub>DS</sub> = 520 V, T <sub>C</sub> = 125°C	--	2.0	--	uA
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	V <sub>GS</sub> = 30 V, V <sub>DS</sub> = 0 V	--	--	100	nA
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	V <sub>GS</sub> = -30 V, V <sub>DS</sub> = 0 V	--	--	-100	nA

### On Characteristics

V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250uA	2.5	--	4.5	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 4A	--	318	380	mΩ

### Dynamic Characteristics

C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 400 V, V <sub>GS</sub> = 0 V, f = 250KHz	--	624	--	pF
C <sub>oss</sub>	Output Capacitance		--	17	--	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		--	--	--	pF

### Switching Characteristics

t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DS</sub> = 400 V, I <sub>D</sub> = 4A, R <sub>G</sub> = 10Ω, V <sub>GS</sub> = 10 V (Note 4, 5)	--	9	--	ns
t <sub>r</sub>	Turn-On Rise Time		--	9	--	ns
t <sub>d(off)</sub>	Turn-Off Delay Time		--	39	--	ns
t <sub>f</sub>	Turn-Off Fall Time		--	10	--	ns
Q <sub>g</sub>	Total Gate Charge	V <sub>DS</sub> = 400 V, I <sub>D</sub> = 4 A, V <sub>GS</sub> = 10 V (Note 4, 5)	--	16.5	--	nC
Q <sub>gs</sub>	Gate-Source Charge		--	3.4	--	nC
Q <sub>gd</sub>	Gate-Drain Charge		--	8.2	--	nC
R <sub>G</sub>	Gate Resistance	f = 1MHz		6.9		Ω

### Drain-Source Diode Characteristics and Maximum Ratings

I <sub>S</sub>	Maximum Continuous Drain-Source Diode Forward Current	--	--	9.6	A
I <sub>SM</sub>	Maximum Pulsed Drain-Source Diode Forward Current	--	--	28.8	A
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 4A	--	--	1.2
t <sub>rr</sub>	Reverse Recovery Time	V <sub>DD</sub> = 400 V, I <sub>S</sub> = 4A, dI <sub>F</sub> / dt = 100 A/us (Note 4)	--	220	--
Q <sub>rr</sub>	Reverse Recovery Charge		--	1.78	--

#### Notes:

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2. I<sub>AS</sub> = 2.5A, V<sub>DD</sub> = 50V, R<sub>G</sub> = 25Ω, Starting T<sub>J</sub> = 25°C
3. I<sub>SD</sub> ≤ 4A, dI/dt ≤ 100A/us, V<sub>DD</sub> ≤ 400, Starting T<sub>J</sub> = 25°C
4. Pulse Test : Pulse width ≤ 300us, Duty cycle ≤ 2%
5. Essentially independent of operating temperature

## Typical Characteristics

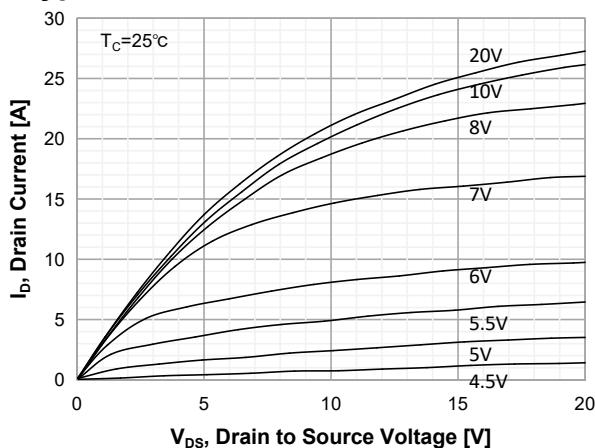


Figure 1. On-Region Characteristics

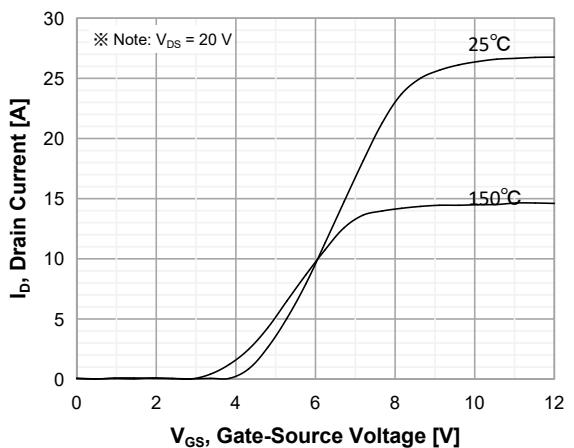


Figure 2. Transfer Characteristics

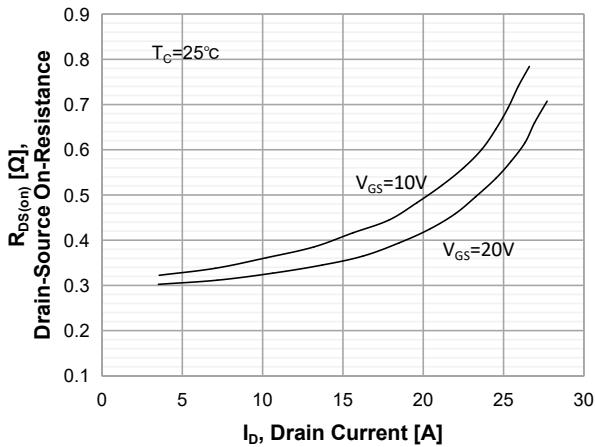


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

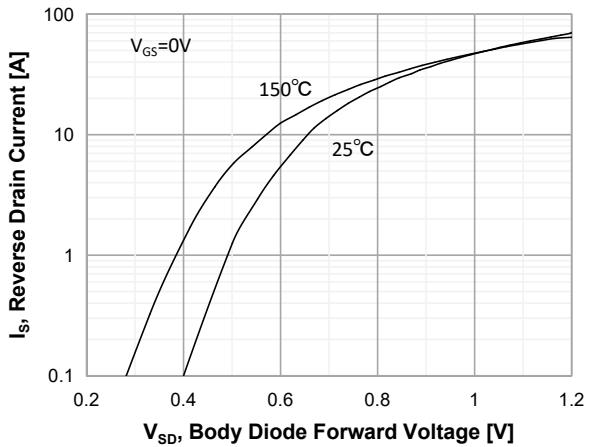


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

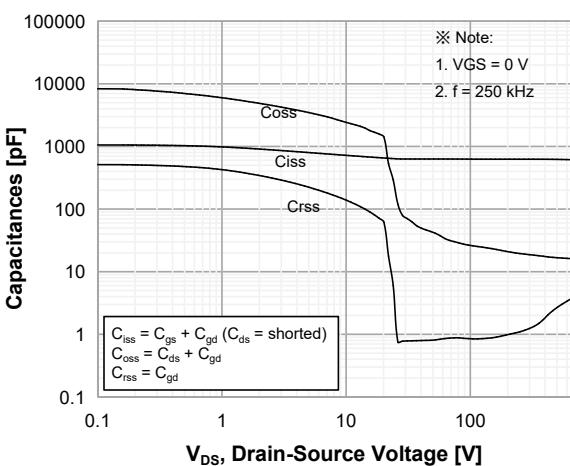


Figure 5. Capacitance Characteristics

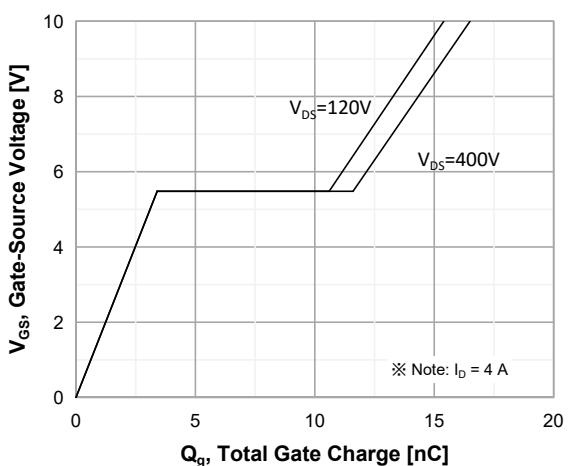


Figure 6. Gate Charge Characteristics

## Typical Characteristics (Continued)

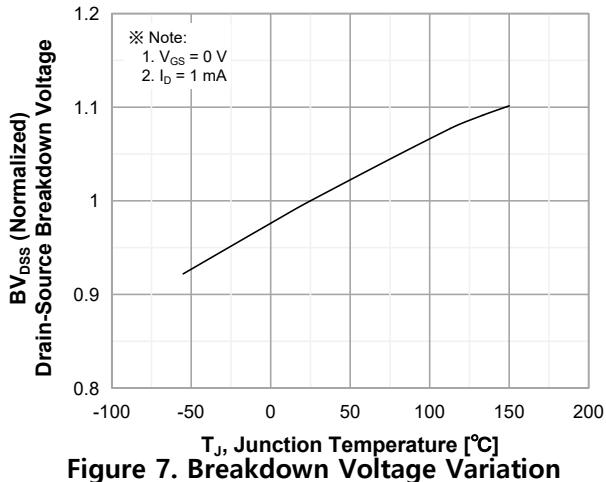


Figure 7. Breakdown Voltage Variation  
vs Temperature

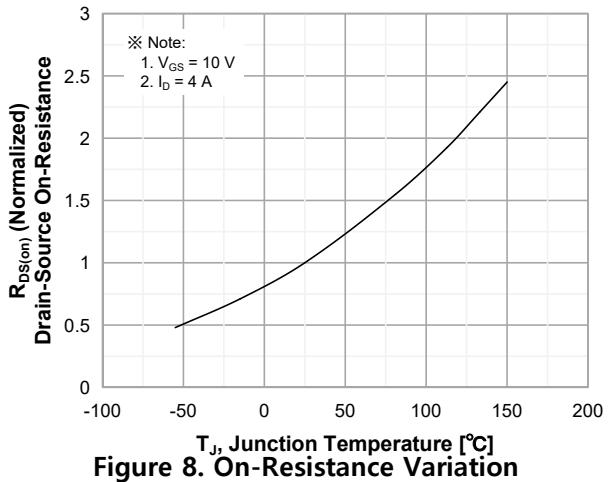


Figure 8. On-Resistance Variation  
vs Temperature

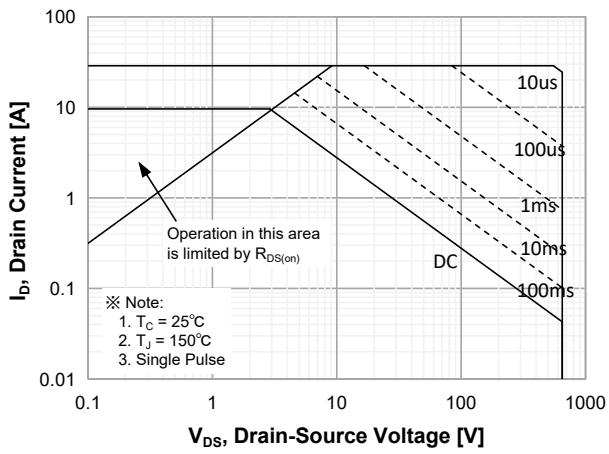


Figure 9. Maximum Safe Operating Area

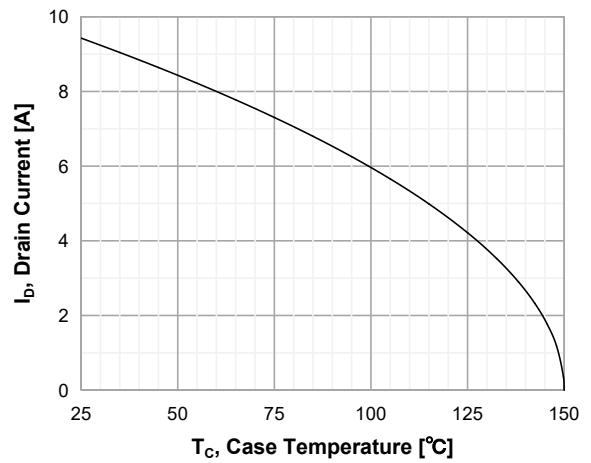


Figure 10. Maximum Drain Current vs.  
Case Temperature

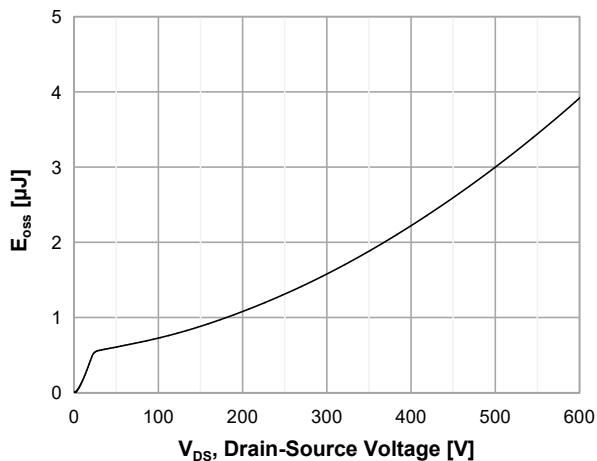


Figure 11.  $E_{oss}$  vs. Drain to Source Voltage

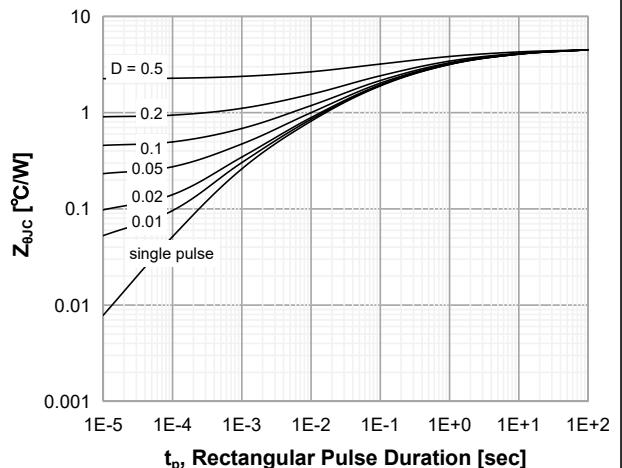
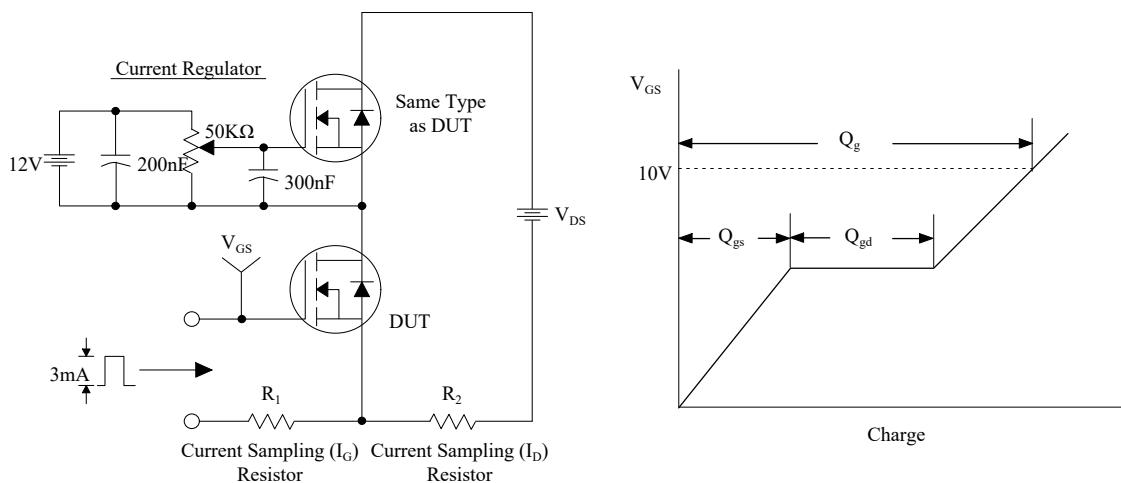
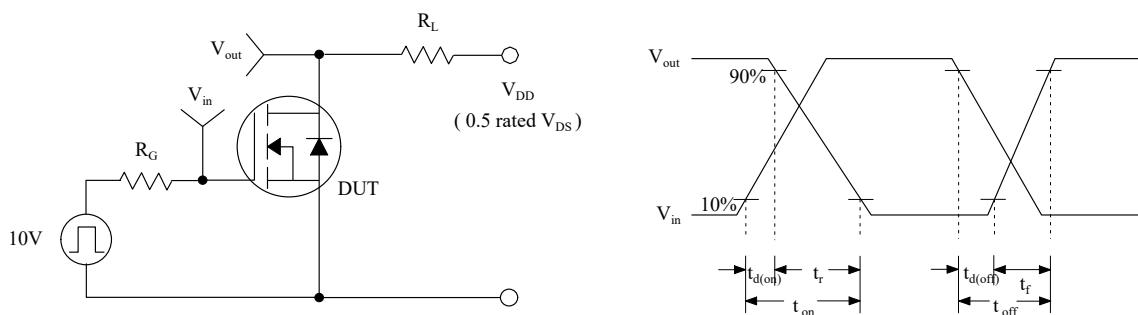


Figure 12. Transient Thermal Response Curve

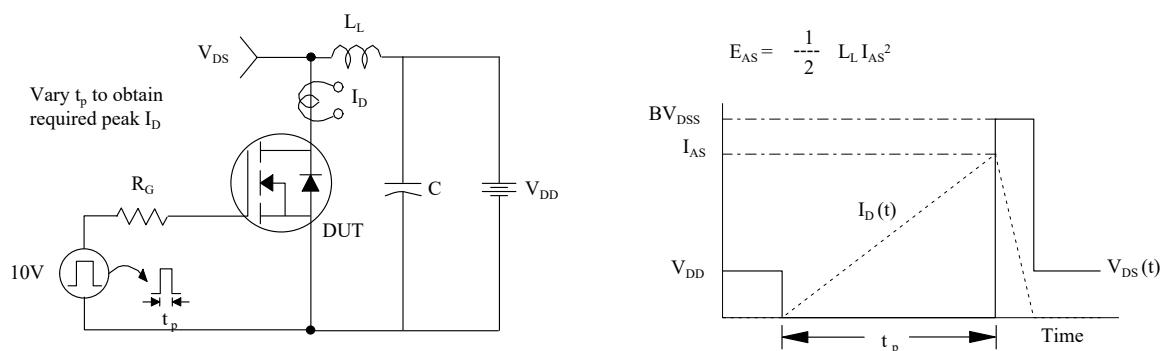
## Gate Charge Test Circuit & Waveform



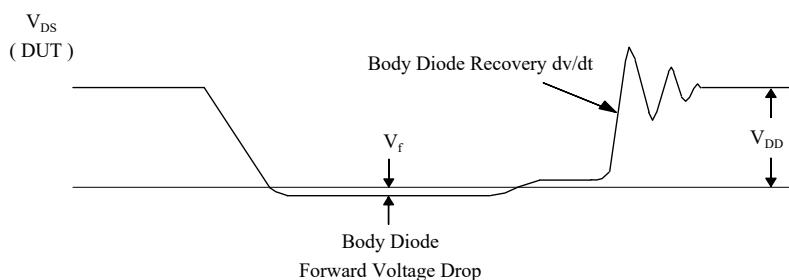
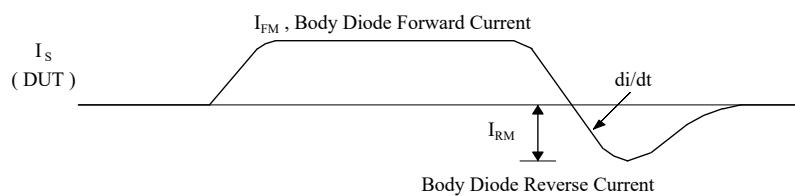
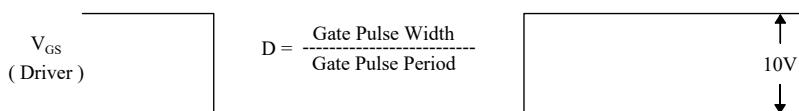
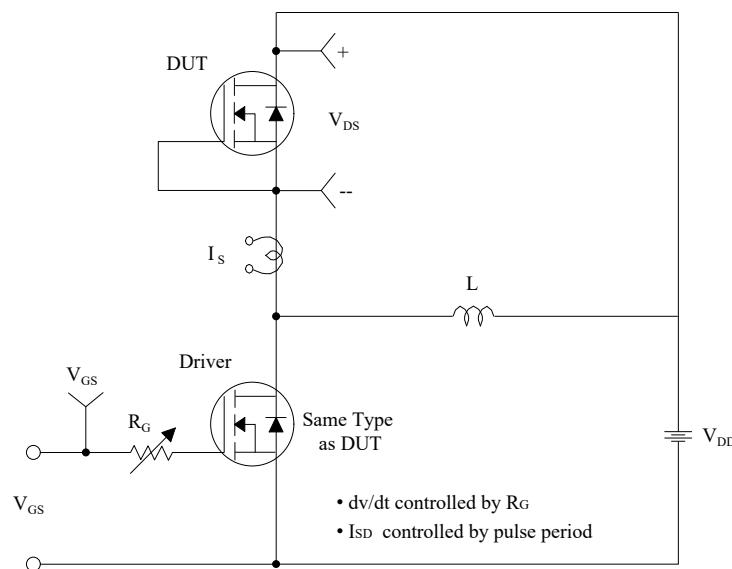
## Resistive Switching Test Circuit & Waveforms



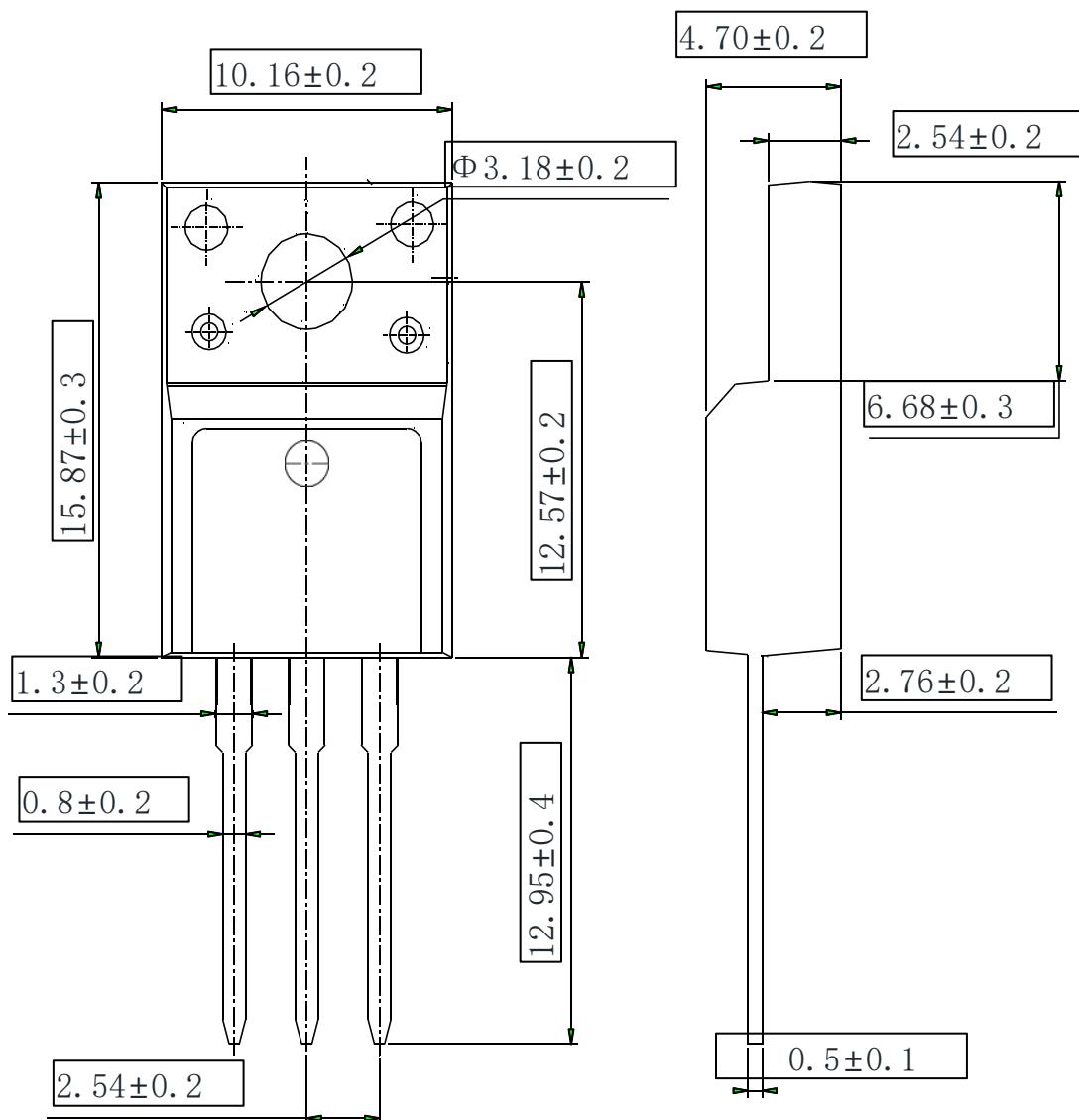
## Unclamped Inductive Switching Test Circuit & Waveforms



## Peak Diode Recovery dv/dt Test Circuit & Waveforms



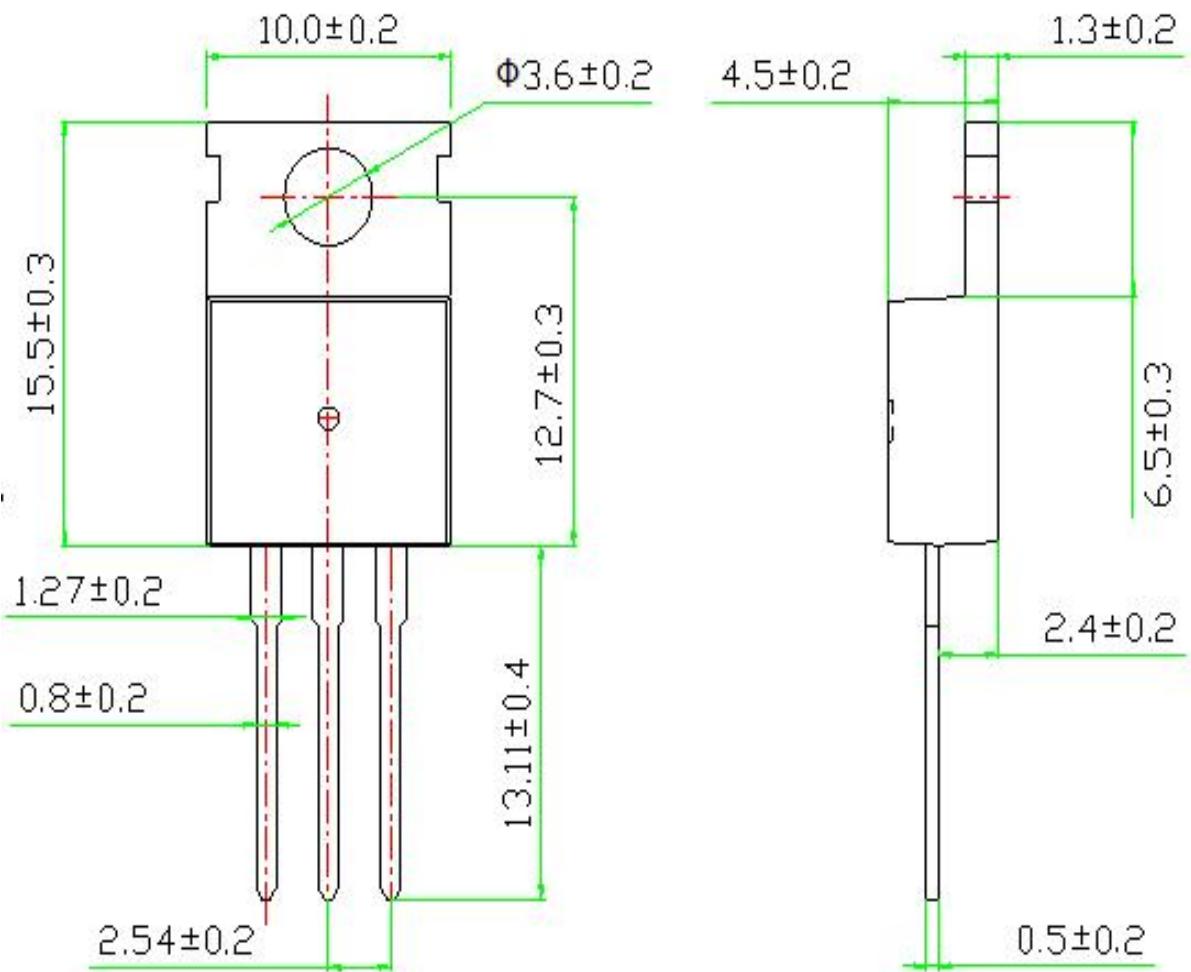
## TO-220F OUTLINE



## NOTE:

- 1The plastic package is not marked as smooth surfaceRa=0.1;Subglossy surfaceRa=0.8
- 2.Undeclared tolerance $\pm 0.15$ ,Unmarked filletRmax=0.25

## TO-220C OUTLINE



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